

## **Search Notes**



**Application/Control No.**

10/749,396

Examiner

Wen-Ying P. Chen

**Applicant(s)/Patent under  
Reexamination**

YAMAMOTO, TAKESHI

## **Art Unit**

2871

**SEARCHED**

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner